Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	,	Application No. 09/718,155	
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	Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate			
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KL	AF	3-228266	10/09/91	Japan			X			
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KL	AH	2000-40302	02/08/00	Japan			X			
KL	AI	10-49990	02/20/98	Japan			X			
ke	AJ	10-63433	03/06/98	Japan			X			
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Attorney's Docket No. 10449-026001

Application No. 09/718,155

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Koji Hayashi Filing Date

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U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. Application No. 10449-026001 09/718,155

Applicant

Koji Hayashi

Filing Date November 21, 2000

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